- Inputs Are TTL-Voltage Compatible
- **EPIC<sup>™</sup>** (Enhanced-Performance Implanted **CMOS) Process**
- Latch-Up Performance Exceeds 250 mA Per **JESD 17**
- ESD Protection Exceeds 2000 V Per MIL-STD-833, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)
- **Package Options Include Plastic** Small-Outline (D), Shrink Small-Outline (DB), Thin Very Small-Outline (DGV), Thin Shrink Small-Outline (PW), and Ceramic Flat (W) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) DIPs

### description

These quadruple 2-line 1-line data to selectors/multiplexers are designed for 4.5-V to 5.5-V V<sub>CC</sub> operation.

The 'AHCT158 devices feature a common strobe  $(\overline{G})$  input. When the strobe is high, all outputs are high. When the strobe is low, a 4-bit word is selected from one of two sources and is routed to the four outputs. The devices provide inverted data.

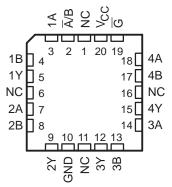
The SN54AHCT158 is characterized for operation over the full military temperature range of -55°C to 125°C. The SN74AHCT158 is characterized for operation from -40°C to 85°C.

(TOP VIEW)
A/B 1 16 V <sub>CC</sub> 1A 2 15 G   1B 3 14 4A   1Y 4 13 4B   2A 5 12 4Y   2B 6 11 3A   2Y 7 10 3B   GND 8 9 3Y

SN54AHCT158 ... J OR W PACKAGE SN74AHCT158 . . . D, DB, DGV, N, OR PW PACKAGE

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SN54AHCT158 ... FK PACKAGE (TOP VIEW)



NC - No internal connection

	FUNCTION TABLE										
	INPU	OUTPUT									
G	Ā/B	Α	В	Y							
Н	Х	Х	Х	Н							
L	L	L	Х	Н							
L	L	Н	х	L							
L	Н	Х	L	Н							
L	Н	Х	н	L							

FU	NC.	ΓΙΟ	ΝT	AB	LE	



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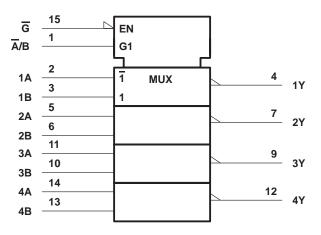
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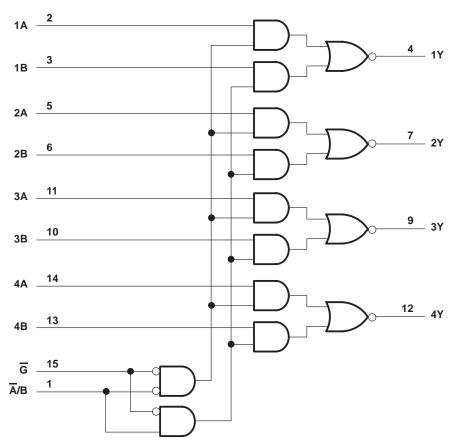
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### logic symbol<sup>†</sup>



<sup>†</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for the D, DB, DGV, J, N, PW, and W packages.

## logic diagram (positive logic)



Pin numbers shown are for the D, DB, DGV, J, N, PW, and W packages.



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### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)<sup>†</sup>

Supply voltage range, $V_{CC}$ Input voltage range, $V_I$ (see Note 1) Output voltage range, $V_O$ (see Note 1) Input clamp current, $I_{IK}$ ( $V_I < 0$ ) Output clamp current, $I_{OK}$ ( $V_O < 0$ or $V_O > V_C$ Continuous output current, $I_O$ ( $V_O = 0$ to $V_{CC}$ ) Continuous current through $V_{CC}$ or GND Package thermal impedance, $\theta_{JA}$ (see Note 2)	2): D package DB package DGV package N package	$\begin{array}{c} -0.5 \ V \ to \ 7 \ V \\ V \ to \ V_{CC} + 0.5 \ V \\ -20 \ mA \\ \pm 20 \ mA \\ \pm 25 \ mA \\ \pm 25 \ mA \\ 113^{\circ}C/W \\ 131^{\circ}C/W \\ 130^{\circ}C/W \\ -180^{\circ}C/W \\ -78^{\circ}C/W \end{array}$
Storage temperature range, T <sub>stg</sub>	PW package	149°C/W

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.
  - 2. The package thermal impedance is calculated in accordance with JESD 51, except for through-hole packages, which use a trace length of zero.

### recommended operating conditions (see Note 3)

		SN54AHCT158		SN74AH	UNIT	
		MIN	MAX	MIN	MAX	UNIT
VCC	Supply voltage	4.5	5.5	4.5	5.5	V
VIH	High-level input voltage	2	Ŋ	2		V
VIL	Low-level input voltage		0.8		0.8	V
VI	Input voltage	0	5.5	0	5.5	V
Vo	Output voltage	0	VCC	0	VCC	V
ЮН	High-level output current	DN2	-8		-8	mA
IOL	Low-level output current	104	8		8	mA
$\Delta t/\Delta v$	Input transition rise or fall time	9	20		20	ns/V
ТА	Operating free-air temperature	-55	125	-40	85	°C

NOTE 3: All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.



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# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	$T_A = 25^{\circ}C$		SN54AH	CT158	SN74AH	UNIT			
PARAMETER	TEST CONDITIONS	Vcc	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
Maria	I <sub>OH</sub> = -50 μA	4.5.1	4.4	4.5		4.4		4.4		V
VOH	I <sub>OH</sub> = -8 mA	4.5 V	3.94			3.8	Ņ	3.8		V
Max	I <sub>OL</sub> = 50 μA	4.5.1			0.1		0.1		0.1	
VOL	I <sub>OL</sub> = 8 mA	4.5 V			0.36		0.44		0.44	V
lį	$V_{I} = V_{CC}$ or GND	5.5 V			±0.1	4	1		±1	μΑ
ICC	$V_{I} = V_{CC} \text{ or GND}, \qquad I_{O} = 0$	5.5 V			2	nc	20		20	μΑ
$\Delta I CC^{\dagger}$	One input at 3.4 V, Other inputs at V <sub>CC</sub> or GND	5.5 V			1.35	Odd	1.5		1.5	mA
Ci	$V_{I} = V_{CC} \text{ or } GND$	5 V		2	10				10	pF

<sup>†</sup> This is the increase in supply current for each input at one of the specified TTL voltage levels rather than 0 V or V<sub>CC</sub>.

# switching characteristics over recommended operating free-air temperature range, $V_{CC}$ = 5 V $\pm$ 0.5 V (unless otherwise noted) (see Figure 1)

				SI	154AHCT	158				
PARAMETER	FROM (INPUT)	TO (OUTPUT)	LOAD CAPACITANCE	T <sub>A</sub> = 25	°C	MIN	MAX	UNIT		
		(001101)	OALAONANOE	MIN TYF	MAX		WAX			
<sup>t</sup> PLH*	A or B	Y	C <sub>L</sub> = 15 pF	4.1	6.4	1	7.5	ns		
<sup>t</sup> PHL <sup>*</sup>	AUB	T		4.1	6.4	1	7.5	115		
<sup>t</sup> PLH*	· Ā/B	Y C <sub>L</sub> = 15 pF	C: 15 pF	5.3	8.1	1	9.5	ns		
<sup>t</sup> PHL <sup>*</sup>			5.3	8.1	1	9.5	115			
<sup>t</sup> PLH <sup>*</sup>	G	Y	C <sub>L</sub> = 15 pF	5.6	8.6	1	10	ns		
<sup>t</sup> PHL*	G	T	I			5.6	8.6	1	10	115
<sup>t</sup> PLH	A or B	Y	C <sub>1</sub> = 50 pF	5.6	8.7	1	10.8	ns		
<sup>t</sup> PHL	AUB	T		5.6	8.7	1	10.8	115		
<sup>t</sup> PLH	Ā/B	Y	C1 = 50 pF	6.8	10.4	1	13.2	ns		
<sup>t</sup> PLH	A/B	T		6.8	10.4	1	13.2	115		
<sup>t</sup> PLH	G	Y	C <sub>L</sub> = 50 pF	7.1	11	1	13.5			
<sup>t</sup> PHL	6	ľ	CL = 50 pF	7.1	11	1	13.5	ns		

\* On products compliant to MIL-PRF-38535, this parameter is not production tested.

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# switching characteristics over recommended operating free-air temperature range, $V_{CC}$ = 5 V $\pm$ 0.5 V (unless otherwise noted) (see Figure 1)

				SN74AHCT158						
PARAMETER	FROM (INPUT)	TO (OUTPUT)	LOAD CAPACITANCE	T <sub>A</sub> =	25°C		MIN	MAX	UNIT	
		(001101)	OALAONANOE	MIN T	ΥP	MAX	IVIIN	WAX		
<sup>t</sup> PLH	A or B	Y	C <sub>L</sub> = 15 pF		4.1	6.4	1	7.5	ns	
<sup>t</sup> PHL	AOIB	I	0 <u></u> = 15 pr		4.1	6.4	1	7.5	115	
<sup>t</sup> PLH	Ā/B	Y	CL = 15 pF		5.3	8.1	1	9.5	ns	
<sup>t</sup> PHL	A/B	T		5.3 8.1	5.3	1	9.5	115		
<sup>t</sup> PLH	G	Y	Y	C <sub>L</sub> = 15 pF		5.6	8.6	1	10	ns
<sup>t</sup> PHL	9					5.6	8.6	1	10	115
<sup>t</sup> PLH	A or B	Y	Y C <sub>L</sub> = 50 pF		5.6	8.7	1	9.8		
<sup>t</sup> PHL	AULP	Ţ	CL = 50 pF		5.6	8.7	1	9.8	ns	
<sup>t</sup> PLH	-	Y	C <sub>1</sub> = 50 pF		6.8	10.4	1	12	ns	
<sup>t</sup> PLH	Ā/B	τ CL = 50 pr			6.8	10.4	1	12	115	
<sup>t</sup> PLH	G	Y	C <sub>L</sub> = 50 pF		7.1	10.6	1	12	ns	
<sup>t</sup> PHL	9		0L = 50 pF		7.1	10.6	1	12	115	

## noise characteristics V<sub>CC</sub> = 5 V, C<sub>L</sub> = 50 pF, T<sub>A</sub> = 25°C (see Note 4)

	PARAMETER		SN74AHCT158			
		MIN	MIN TYP MAX		UNIT	
VOL(P)	Quiet output, maximum dynamic V <sub>OL</sub>			0.8	V	
VOL(V)	Quiet output, minimum dynamic V <sub>OL</sub>			-0.8	V	
VOH(V)	Quiet output, minimum dynamic V <sub>OH</sub>		4.8		V	
V <sub>IH(D)</sub>	High-level dynamic input voltage	2			V	
V <sub>IL(D)</sub>	Low-level dynamic input voltage			0.8	V	

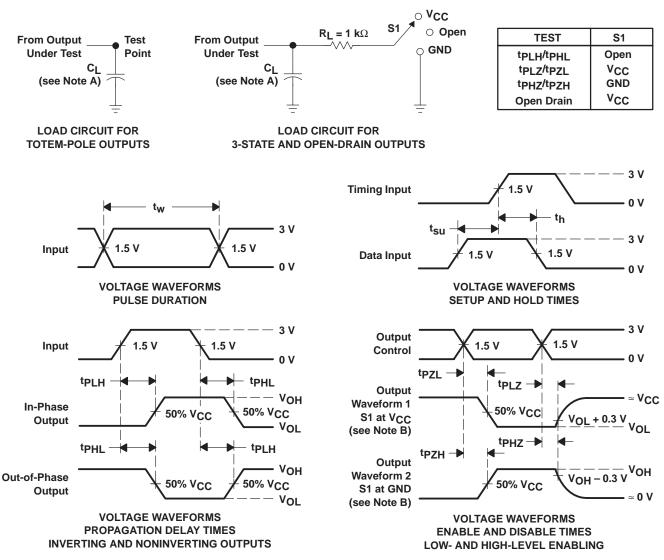
NOTE 4: Characteristics are for surface-mount packages only.

## operating characteristics, $V_{CC}$ = 5 V, $T_A$ = 25°C

PARAMETER		TEST CO	ONDITIONS	TYP	UNIT
C <sub>pd</sub>	Power dissipation capacitance	No load,	f = 1 MHz	11	pF



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### PARAMETER MEASUREMENT INFORMATION

NOTES: A. CL includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  1 MHz, Z<sub>O</sub> = 50  $\Omega$ , t<sub>f</sub>  $\leq$  3 ns, t<sub>f</sub>  $\leq$  3 ns.

D. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



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